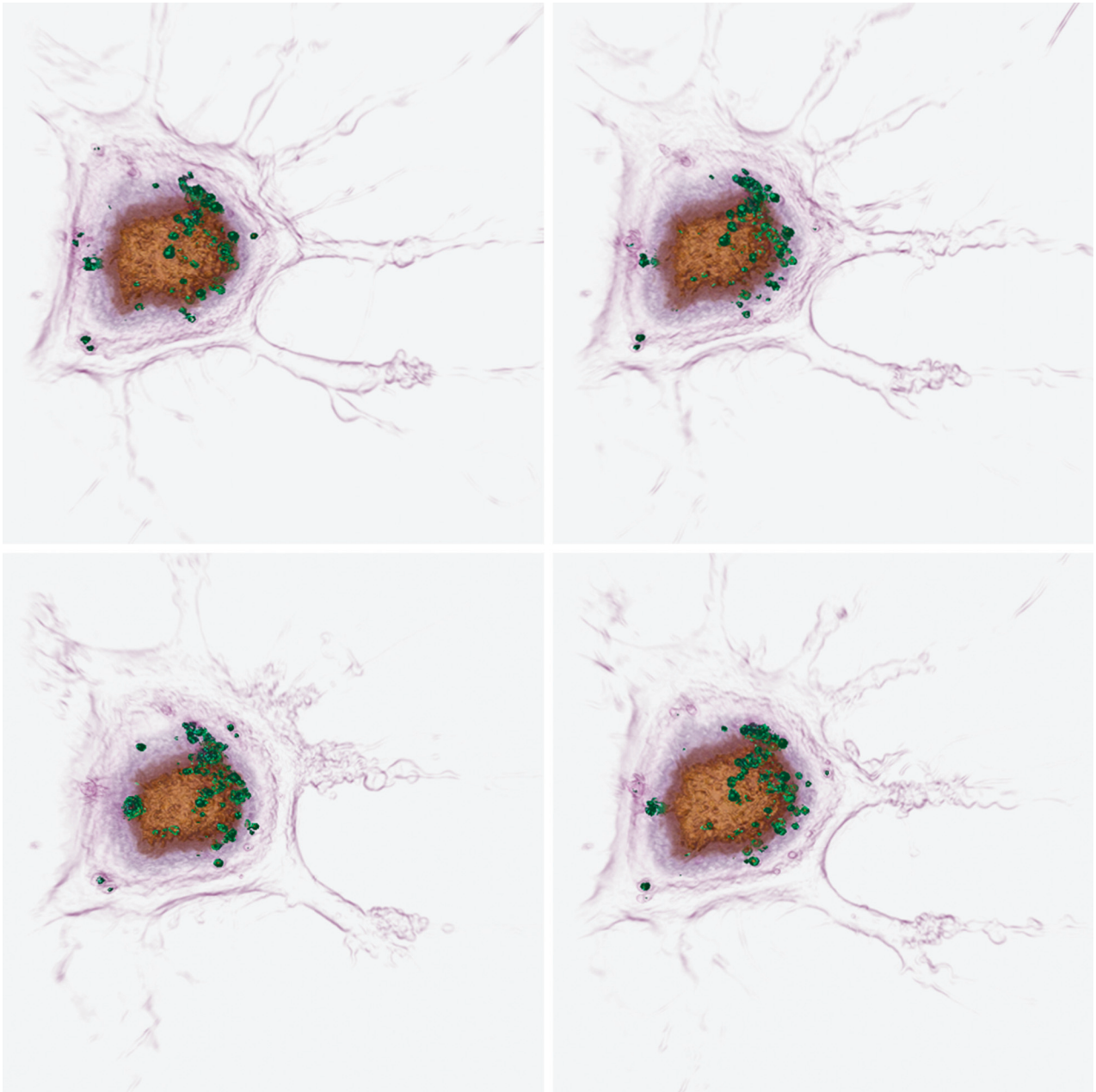


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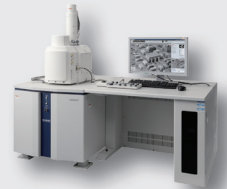
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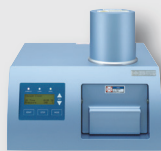
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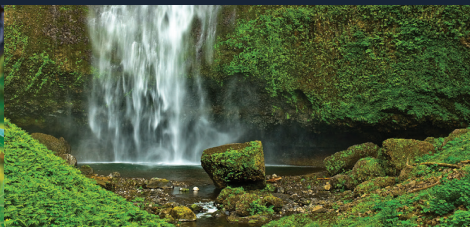
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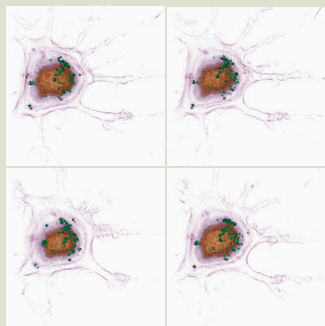
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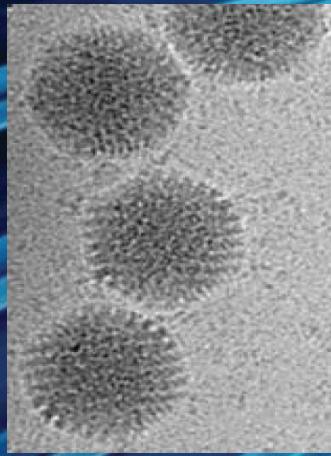
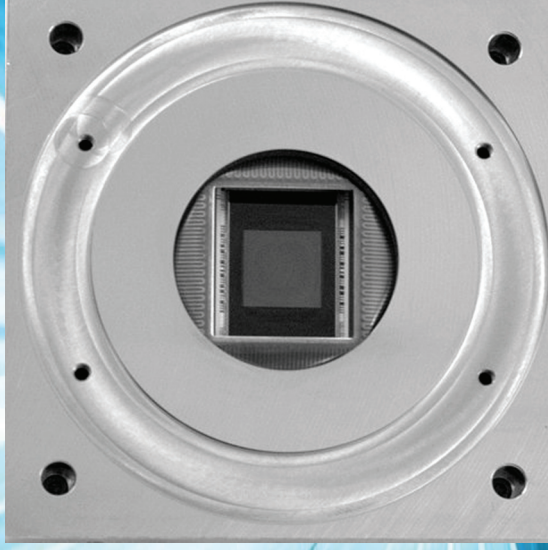
Clockwise from upper left: digitally stained mouse fibroblastic reticular cell in the process of dying. Elapsed time=9.8 minutes. Full width=57 μm.

See article by Pollaro et al.



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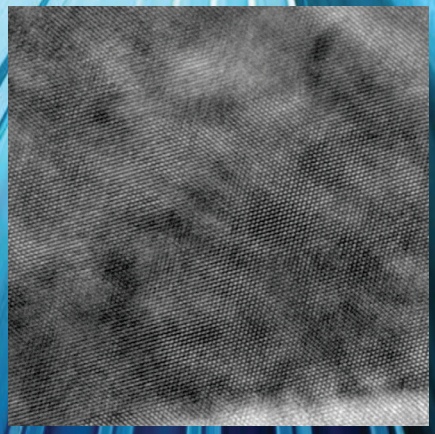
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The Hospital for Sick Children



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